MOSFET - Power, Single P-Channel, μ8FL

-30 V, -88.6 A, 7.5 mΩ

NVTFS015P03P8Z

Features

- Ultra Low R_{DS(on)} to Improve System Efficiency
- Advanced Package Technology in 3.3 x 3.3 mm for Space Saving and Excellent Thermal Conduction
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Load Switch
- Protection: Reverse Current, Over Voltage, and Reverse Negative Voltage
- Battery Management

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Symbol	Parameter			Value	Unit
V _{DSS}	Drain-to-Source Voltage			-30	V
V_{GS}	Gate-to-Source Voltage			± 25	V
I _D	Continuous Drain Cur-	Steady	T _C = 25°C	-88.6	Α
	rent R _{θJC} (Notes 1, 2)	State	T _C = 100°C	-62.6	
P _D	Power Dissipation		T _C = 25°C	88.2	W
	R _{θJC} (Notes 1, 2)		T _C = 100°C	44.1	
I _D	Continuous Drain Cur-	Steady	T _A = 25°C	-17	Α
	rent R _{θJA} (Notes 1, 2)	State	T _A = 100°C	-12	
P_{D}	Power Dissipation $R_{\theta JA}$			3.2	W
	(Notes 1, 2)		T _A = 100°C	1.6	
I _{DM}	Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	-353	Α
T _J , T _{stg}	Operating Junction and Storage Temperature Range			–55 to 175	°C
Is	Source Current (Body Diode)			73.5	Α
E _{AS}	Single Pulse Drain to Source Avalanche Energy (I _L = 8.5 A)			88	mJ
TL	Lead Temperature for So (1/8" from case for 10 s)	oldering Pu	urposes	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Junction-to-Case - Steady State (Drain) (Note 2)	1.7	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 2)	46.4	°C/W

The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

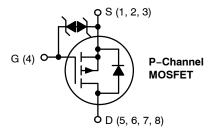
V _{(BR)DSS}	R _{DS(on)}	I _D
-30 V	7.5 mΩ @ −10 V	-88.6 A
	12 mΩ @ -4.5 V	



(µ8FL) CASE 511AB



WDFNW8 (µ8FL WF) CASE 515AN



MARKING DIAGRAMS





XXXXX = Specific Device Code = Assembly Location = Year

\\\\\ = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

NOTE: Some of the devices on this data sheet have been **DISCONTINUED.** Please refer to the table on page 5.

^{2.} Surface-mounted on FR4 board using a 1 in2, 2 oz. Cu pad. Assuming a 76 mm x 76 mm x 1.6 mm board.

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Symbol	Parameter	Test Con	dition	Min	Тур	Max	Unit
OFF CHARA	CTERISTICS						
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-30			V
V _{(BR)DSS} /	Drain-to-Source Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, ref to 25°C			-4.4		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V}, V_{DS} = -30 \text{ V}$	T _J = 25°C			-10	μΑ
I _{GSS}	Gate-to-Source Leakage Current	$V_{DS} = 0 V, V_{G}$	_S = ±25 V			±10	μΑ
ON CHARAC	CTERISTICS (Note 3)						
V _{GS(TH)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D}$	= -250 μA	-1.0		-3.0	V
V _{GS(TH)} /T _J	Threshold Temperature Coefficient	$I_D = -250 \mu A$,	ref to 25°C		5.6		mV/°C
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = -10 V,	_D = -12 A		5.0	7.5	mΩ
		$V_{GS} = -4.5 \text{ V},$	I _D = -10 A		8.0	12	
9FS	Froward Transconductance	V _{DS} = -5 V, I _D = -10 A			77		S
CHARGES A	ND CAPACITANCES				•	•	
C _{iss}	Input Capacitance	$V_{GS} = 0 \text{ V, } f = 1.0 \text{ MHz,}$ $V_{DS} = -15 \text{ V}$			2706		pF
C _{oss}	Output Capacitance				907		1
C _{rss}	Reverse Transfer Capacitance				875		
Q _{G(TOT)}	Total Gate Charge	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_D = -10 \text{ A}$			37		nC
Q _{G(TH)}	Threshold Gate Charge	I _D = -1		5.1		1	
Q_{GS}	Gate-to-Source Charge				8.2		-
Q_{GD}	Gate-to-Drain Charge				21.7		
Q _{G(TOT)}	Total Gate Charge	$V_{GS} = -10 \text{ V}, V_{DS} = -15 \text{ V},$ $I_D = -10 \text{ A}$			62.3	105	1
SWITCHING	CHARACTERISTICS, V _{GS} = 4.5 V (Note	3)					
t _{d(on)}	Turn-On Delay Time	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$			25		ns
t _r	Rise Time	$I_D = -10 \text{ A}, \text{ F}$	$R_{G} = 6 \Omega$		138		-
t _{d(off)}	Turn-Off Delay Time				55		
t _f	Fall Time				98		
SWITCHING	CHARACTERISTICS, V _{GS} = 10 V (Note 3	3)					
t _{d(on)}	Turn-On Delay Time	V _{GS} = -10 V, V			6		ns
t _r	Rise Time	$I_{D} = -10 \text{ A}, F$	t _G = 6 Ω		17		1
t _{d(off)}	Turn-Off Delay Time				52		1
t _f	Fall Time				63		
DRAIN-SOU	RCE DIODE CHARACTERISTICS				-	-	
V _{SD}	Forward Diode Voltage	V _{GS} = 0 V,	T _J = 25°C		-0.8	-1.3	V
		$I_{S} = -10 \text{ A}$	T _J = 125°C		-0.65		1
t _{RR}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, dl}_s/ds$	= 100 A/μs,		40.7		ns
ta	Charge Time	l _s = -10 A			18.4		1
t _b	Discharge Time				22.3		1
Q _{RR}	Reverse Recovery Charge				29		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: Pulse Width \leq 300 µs, Duty Cycle \leq 2%.

TYPICAL CHARACTERISTICS

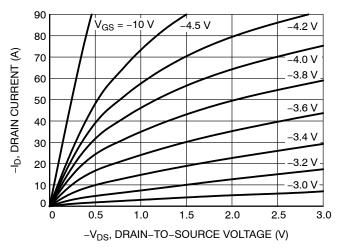


Figure 1. On-Region Characteristics

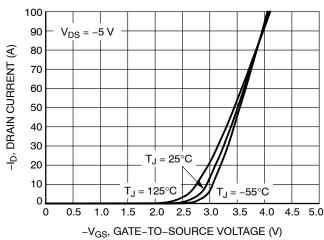


Figure 2. Transfer Characteristics

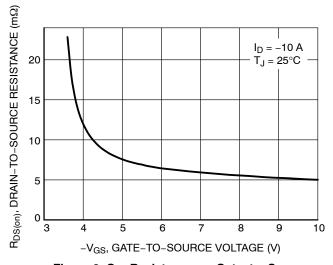


Figure 3. On-Resistance vs. Gate-to-Source Voltage

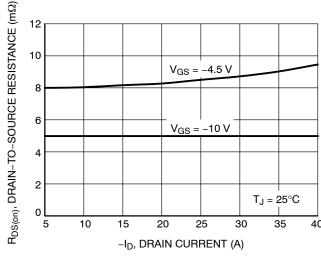


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

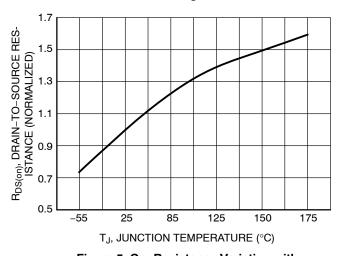


Figure 5. On–Resistance Variation with Temperature

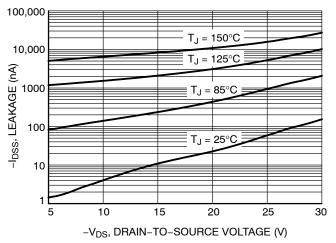


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS (continued)

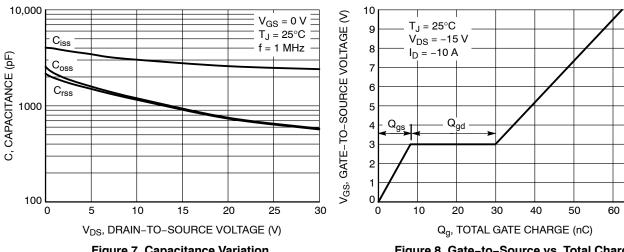


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

70

1.0

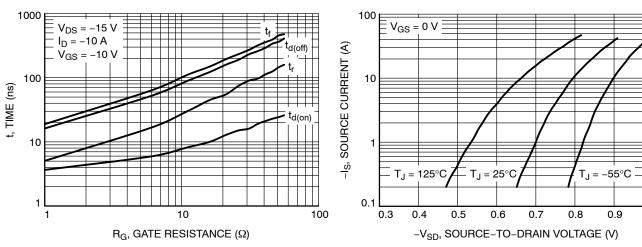


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

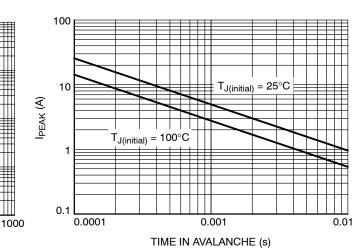


Figure 10. Diode Forward Voltage vs. Current

 $V_{GS} \le 10 \text{ V}$ Single Pulse $T_C = 25^{\circ}C$ ID, DRAIN CURRENT (A) 100 10 μs 10

1000

0.1

0.1

R_{DS(on)} Limit Thermal Limit Package Limit

Figure 11. Maximum Rated Forward Biased Safe Operating Area

10

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

.5 ms

1 ms ↓ l0 ms

100

Figure 12. Maximum Drain Current vs. Time in **Avalanche**

TYPICAL CHARACTERISTICS (continued)

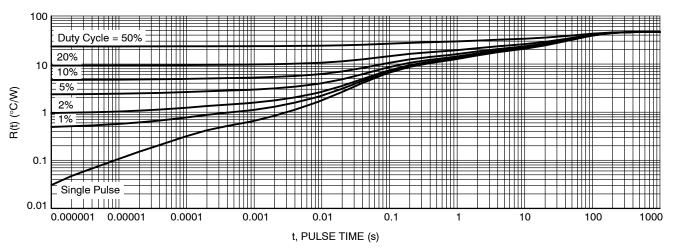


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFWS015P03P8ZTAG	15PW	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

DISCONTINUED (Note 4)

NVTFS015P03P8ZTAG	15P3	WDFN8	1500 / Tape & Reel
		(Pb-Free)	·

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{4.} **DISCONTINUED:** This device is not recommended for new design. Please contact your **onsemi** representative for information. The most current information on this device may be available on www.onsemi.com.



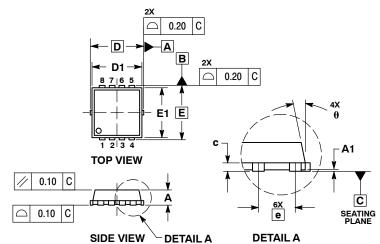




SCALE 2:1

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS		INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC		(0.026 BS0)
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

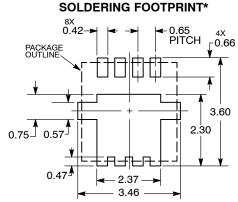


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year = Work Week WW = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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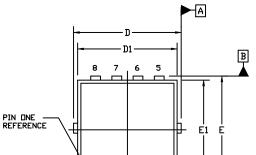
^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.



WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)

CASE 515AN **ISSUE O**

DATE 25 AUG 2020

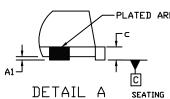


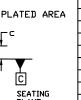
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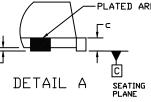
TOP VIEW

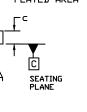


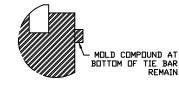
- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M. 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION DI AND EI DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.





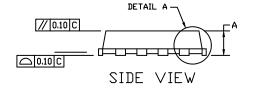




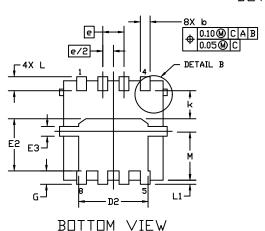


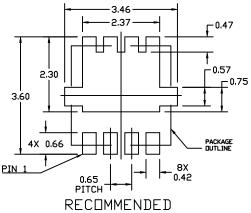
DIM MIN. NDM. MAX. 0.75 0.70 Α 0.80 A1 0.00 0.05 b 0.23 0.30 0.40 0.20 0.25 0.15 c 3.30 3.55 D 3.05 3.15 D1 2.95 3.05 1.98 2.11 2.24 D2 3.05 3.30 3.55 Ε E1 2.95 3.05 3.15 1.47 1.60 1.73 E2 0.40 E3 0.23 0.30 0.65 BS0 e 0.30 0.41 0.51 G Κ 0.65 0.80 0.95 0.59 0.30 0.43 1 L1 0.06 0.13 0.20 1.40 1.50 М 1.60

MILLIMETERS



DETAIL B





MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXX AYWW= XXXX = Specific Device Code

= Assembly Location

= Year WW = Work Week = Pb-Free Package *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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